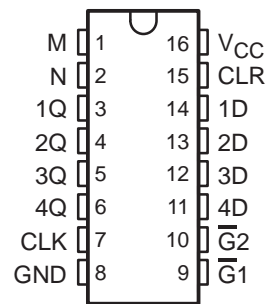


# SN54173, SN54LS173A, SN74173, SN74LS173A 4-BIT D-TYPE REGISTERS WITH 3-STATE OUTPUTS

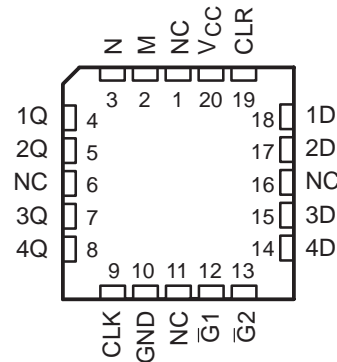
SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

- 3-State Outputs Interface Directly With System Bus
- Gated Output-Control Lines for Enabling or Disabling the Outputs
- Fully Independent Clock Virtually Eliminates Restrictions for Operating in One of Two Modes:
  - Parallel Load
  - Do Nothing (Hold)
- For Application as Bus Buffer Registers
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

SN54173, SN54LS173A . . . J OR W PACKAGE  
SN74173 . . . N PACKAGE  
SN74LS173A . . . D OR N PACKAGE  
(TOP VIEW)



SN54LS173A . . . FK PACKAGE  
(TOP VIEW)



NC – No internal connection

TYPE	TYPICAL PROPAGATION DELAY TIME	MAXIMUM CLOCK FREQUENCY
'173	23 ns	35 MHz
'LS173A	18 ns	50 MHz

## description

The '173 and 'LS173A 4-bit registers include D-type flip-flops featuring totem-pole 3-state outputs capable of driving highly capacitive or relatively low-impedance loads. The high-impedance third state and increased high-logic-level drive provide these flip-flops with the capability of being connected directly to and driving the bus lines in a bus-organized system without need for interface or pull-up components. Up to 128 of the SN74173 or SN74LS173A outputs can be connected to a common bus and still drive two Series 54/74 or 54LS/74LS TTL normalized loads, respectively. Similarly, up to 49 of the SN54173 or SN54LS173A outputs can be connected to a common bus and drive one additional Series 54/74 or 54LS/74LS TTL normalized load, respectively. To minimize the possibility that two outputs will attempt to take a common bus to opposite logic levels, the output control circuitry is designed so that the average output disable times are shorter than the average output enable times.

Gated enable inputs are provided on these devices for controlling the entry of data into the flip-flops. When both data-enable ( $\overline{G1}$ ,  $\overline{G2}$ ) inputs are low, data at the D inputs are loaded into their respective flip-flops on the next positive transition of the buffered clock input. Gate output-control (M, N) inputs also are provided. When both are low, the normal logic states (high or low levels) of the four outputs are available for driving the loads or bus lines. The outputs are disabled independently from the level of the clock by a high logic level at either output-control input. The outputs then present a high impedance and neither load nor drive the bus line. Detailed operation is given in the function table.

The SN54173 and SN54LS173A are characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74173 and SN74LS173A are characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS  
INSTRUMENTS**

POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1999, Texas Instruments Incorporated  
On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

# SN54173, SN54LS173A, SN74173, SN74LS173A

## 4-BIT D-TYPE REGISTERS

### WITH 3-STATE OUTPUTS

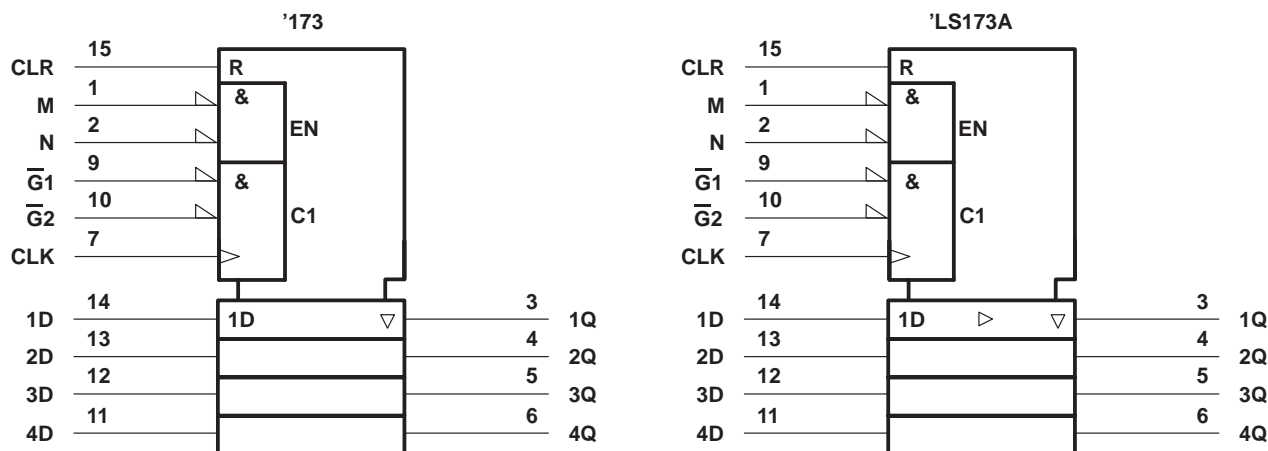
SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

FUNCTION TABLE

CLR	CLK	INPUTS			OUTPUT Q
		DATA ENABLE		DATA D	
		$\overline{G1}$	$\overline{G2}$		
H	X	X	X	X	L
L	L	X	X	X	$Q_0$
L	$\uparrow$	H	X	X	$Q_0$
L	$\uparrow$	X	H	X	$Q_0$
L	$\uparrow$	L	L	L	L
L	$\uparrow$	L	L	H	H

When either M or N (or both) is (are) high, the output is disabled to the high-impedance state; however, sequential operation of the flip-flops is not affected.

### logic symbol†

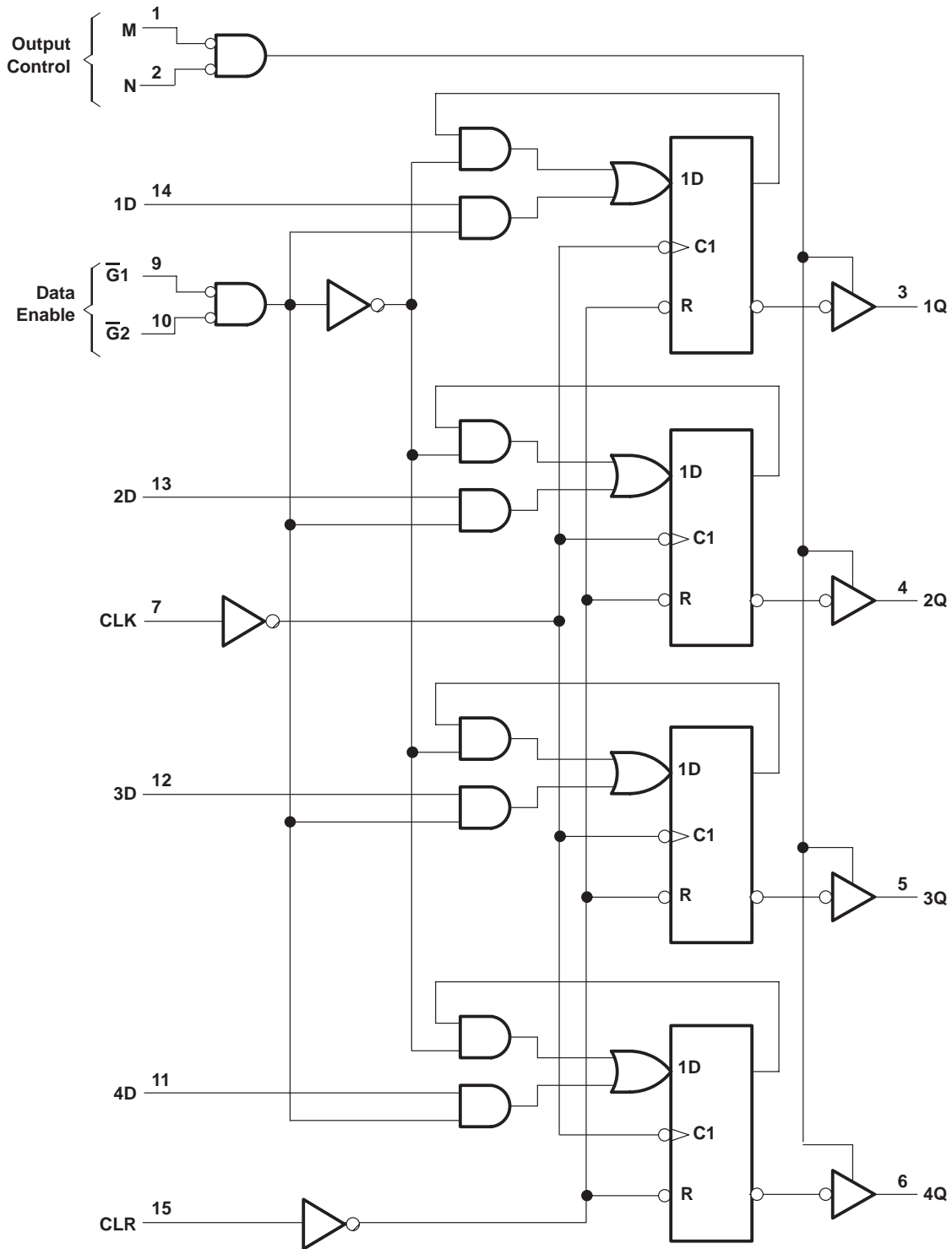


† This symbol is in accordance with ANSI/IEEE Standard 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, N, and W packages.

SN54173, SN54LS173A, SN74173, SN74LS173A  
**4-BIT D-TYPE REGISTERS  
 WITH 3-STATE OUTPUTS**

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

**logic diagram (positive logic)**



Pin numbers shown are for D, J, N, and W packages.

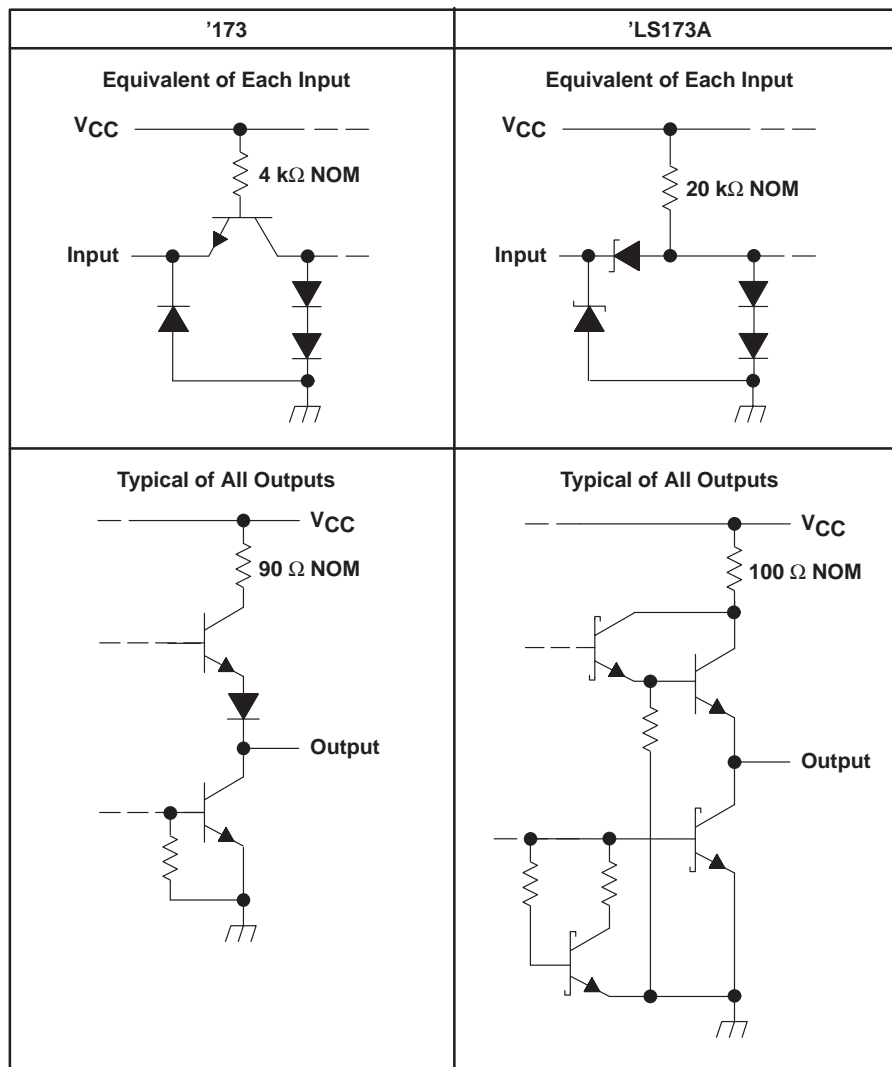
# SN54173, SN54LS173A, SN74173, SN74LS173A

## 4-BIT D-TYPE REGISTERS

### WITH 3-STATE OUTPUTS

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

#### schematics of inputs and outputs



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, $V_{CC}$ (see Note 1)	–0.5 V to 7 V
Input voltage: '173	–0.5 V to 5.5 V
'LS173A	–0.5 V to 7 V
Off-state output voltage	–0.5 V to 5.5 V
Package thermal impedance, $\theta_{JA}$ (see Note 2): D package	113°C/W
N package	78°C/W
Storage temperature range, $T_{stg}$	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Voltage values are with respect to network ground terminal.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

# SN54173, SN54LS173A, SN74173, SN74LS173A 4-BIT D-TYPE REGISTERS WITH 3-STATE OUTPUTS

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

## recommended operating conditions (see Note 3)

		SN54173			SN74173			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
I <sub>OH</sub>	High-level output current			-2			-5.2	mA
I <sub>OL</sub>	Low-level output current			16			16	mA
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN54173			SN74173			UNIT	
		MIN	TYP‡	MAX	MIN	TYP‡	MAX		
V <sub>IH</sub>	High-level input voltage	2			2			V	
V <sub>IL</sub>	Low-level input voltage			0.8			0.8	V	
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA		-1.5			-1.5	V	
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, V <sub>IH</sub> = 2 V, I <sub>OH</sub> = MAX		2.4			2.4	V	
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, V <sub>IH</sub> = 2 V, I <sub>OL</sub> = 16 mA					0.4	V	
I <sub>O(off)</sub>	Off-state (high-impedance state) output current	V <sub>CC</sub> = MAX, V <sub>IH</sub> = 2 V, V <sub>O</sub> = 2.4 V		150			40	μA	
		V <sub>CC</sub> = MAX, V <sub>IH</sub> = 2 V, V <sub>O</sub> = 0.4 V		-150			-40		
I <sub>I</sub>	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V		1			1	mA	
I <sub>IH</sub>	High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V		40			40	μA	
I <sub>IL</sub>	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V		-1.6			-1.6	mA	
I <sub>OS</sub>	Short-circuit output current§	V <sub>CC</sub> = MAX		-30			-70	mA	
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = MAX, See Note 4		50	72		50	72	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time.

NOTE 4: I<sub>CC</sub> is measured with all outputs open; CLR grounded, following momentary connection to 4.5 V, N,  $\overline{G1}$ ,  $\overline{G2}$ , and all data inputs grounded; and CLK and M at 4.5 V.

## timing requirements over recommended operating conditions (unless otherwise noted)

		SN54173		SN74173		UNIT
		MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Input clock frequency		25		25	MHz
t <sub>w</sub>	Pulse duration	CLK or CLR		20	20	ns
t <sub>su</sub>	Setup time	Data enable ( $\overline{G1}$ , $\overline{G2}$ )		17	17	ns
		Data		10	10	
		CLR (inactive state)		10	10	
t <sub>h</sub>	Hold time	Data enable ( $\overline{G1}$ , $\overline{G2}$ )		2	2	ns
		Data		10	10	



**SN54173, SN54LS173A, SN74173, SN74LS173A**  
**4-BIT D-TYPE REGISTERS**  
**WITH 3-STATE OUTPUTS**

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

**switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ ,  $R_L = 400\ \Omega$  (see Figure 1)**

PARAMETER	TEST CONDITIONS	SN54173			SN74173			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
$f_{max}$	Maximum clock frequency	25	35		25	35		MHz
$t_{PHL}$	Propagation delay time, high-to-low-level output from clear input		18	27		18	27	ns
$t_{PLH}$	Propagation delay time, low-to-high-level output from clock input		28	43		28	43	ns
$t_{PHL}$	Propagation delay time, high-to-low-level output from clock input		19	31		19	31	
$t_{PZH}$	Output enable time to high level	7	16	30	7	16	30	ns
$t_{PZL}$	Output enable time to low level	7	21	30	7	21	30	
$t_{PHZ}$	Output disable time from high level	3	5	14	3	5	14	ns
$t_{PLZ}$	Output disable time from low level	3	11	20	3	11	20	



# SN54173, SN54LS173A, SN74173, SN74LS173A 4-BIT D-TYPE REGISTERS WITH 3-STATE OUTPUTS

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

## recommended operating conditions

		SN54LS173A			SN74LS173A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
I <sub>OH</sub>	High-level output current			-1			-2.6	mA
I <sub>OL</sub>	Low-level output current			12			24	mA
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN54LS173A			SN74LS173A			UNIT	
		MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
V <sub>IH</sub>	High-level input voltage	2			2			V	
V <sub>IL</sub>	Low-level input voltage	0.7			0.8			V	
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA			-1.5			V	
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = V <sub>ILmax</sub> , I <sub>OH</sub> = MAX			2.4 3.4			V	
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 12 mA		0.25 0.4		0.25 0.4		V	
		I <sub>OL</sub> = 24 mA				0.35 0.5		V	
I <sub>O(off)</sub>	Off-state (high-impedance state) output current	V <sub>CC</sub> = MAX, V <sub>IH</sub> = 2 V, V <sub>O</sub> = 2.7 V		20		20		V	
		V <sub>O</sub> = 0.4 V		-20		-20			
I <sub>I</sub>	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 7 V			0.1			mA	
I <sub>IH</sub>	High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7 V			20			μA	
I <sub>IL</sub>	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V			-0.4			mA	
I <sub>OS</sub>	Short-circuit output current§	V <sub>CC</sub> = MAX			-30 -130		-30 -130		mA
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = MAX, See Note 4			19 30		19 24		mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time.

NOTE 4: I<sub>CC</sub> is measured with all outputs open; CLR grounded, following momentary connection to 4.5 V, N,  $\overline{G1}$ ,  $\overline{G2}$ , and all data inputs grounded; and CLK and M at 4.5 V.

## timing requirements over recommended operating conditions (unless otherwise noted)

		SN54LS173A		SN74LS173A		UNIT
		MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Input clock frequency	30		25		MHz
t <sub>w</sub>	Pulse duration	CLK or CLR		25		ns
t <sub>su</sub>	Setup time	Data enable ( $\overline{G1}$ , $\overline{G2}$ )		35		ns
		Data		17		
		CLR (inactive state)		10		
t <sub>h</sub>	Hold time	Data enable ( $\overline{G1}$ , $\overline{G2}$ )		0		ns
		Data		3		



**SN54173, SN54LS173A, SN74173, SN74LS173A**  
**4-BIT D-TYPE REGISTERS**  
**WITH 3-STATE OUTPUTS**

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

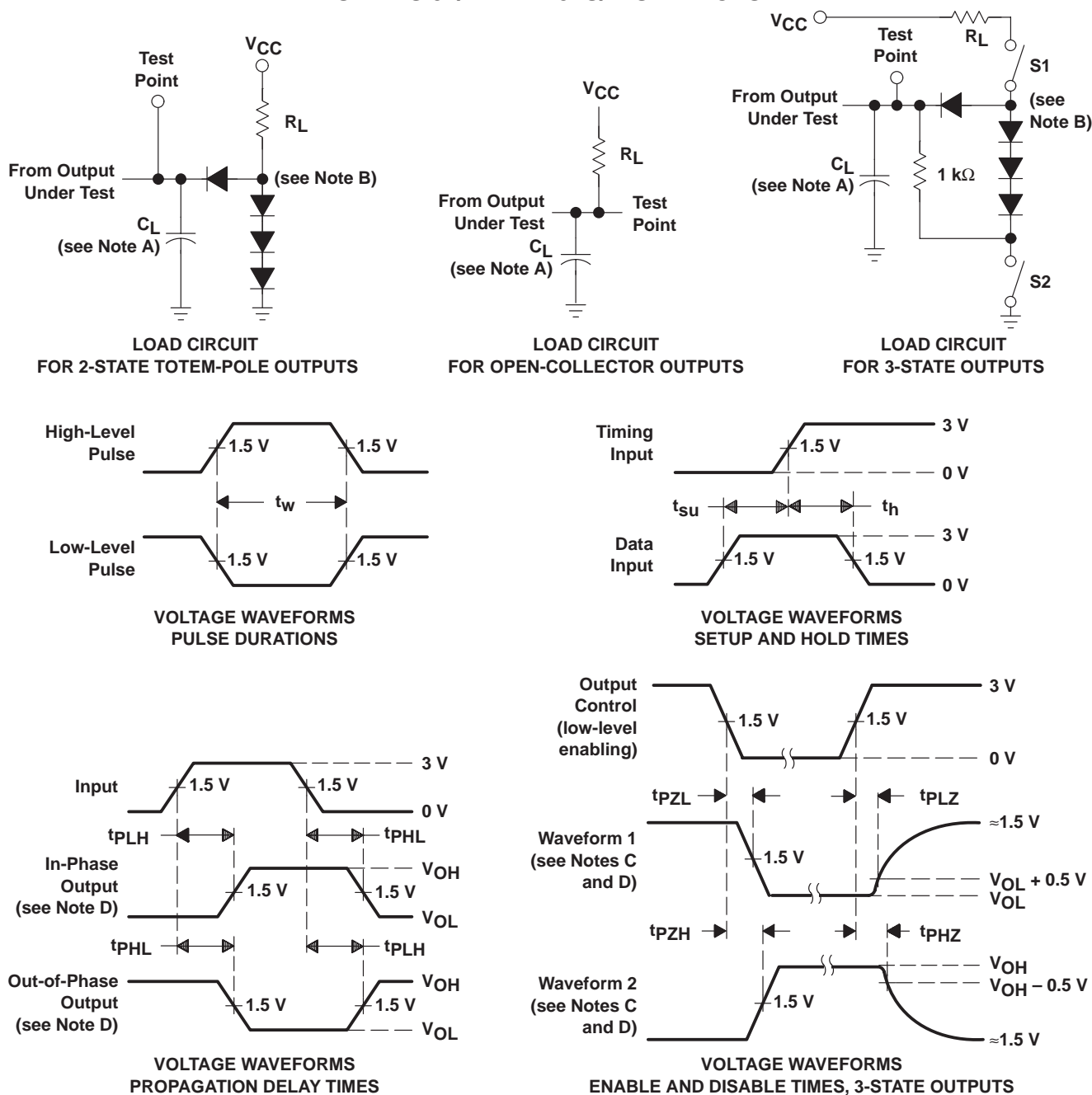
**switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ ,  $R_L = 667\ \Omega$  (see Figure 2)**

PARAMETER		TEST CONDITIONS	SN54LS173A			SN74LS173A			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
$f_{max}$	Maximum clock frequency	$C_L = 45\text{ pF}$	30	50		30	50		MHz	
$t_{PHL}$	Propagation delay time, high-to-low-level output from clear input			26	35		26	35		ns
$t_{PLH}$	Propagation delay time, low-to-high-level output from clock input			17	25		17	25		ns
$t_{PHL}$	Propagation delay time, high-to-low-level output from clock input			22	30		22	30		
$t_{PZH}$	Output enable time to high level			15	23		15	23		ns
$t_{PZL}$	Output enable time to low level			18	27		18	27		
$t_{PHZ}$	Output disable time from high level	$C_L = 5\text{ pF}$		11	20		11	20	ns	
$t_{PLZ}$	Output disable time from low level			11	17		11	17		





PARAMETER MEASUREMENT INFORMATION  
 SERIES 54/74 AND 54S/74S DEVICES



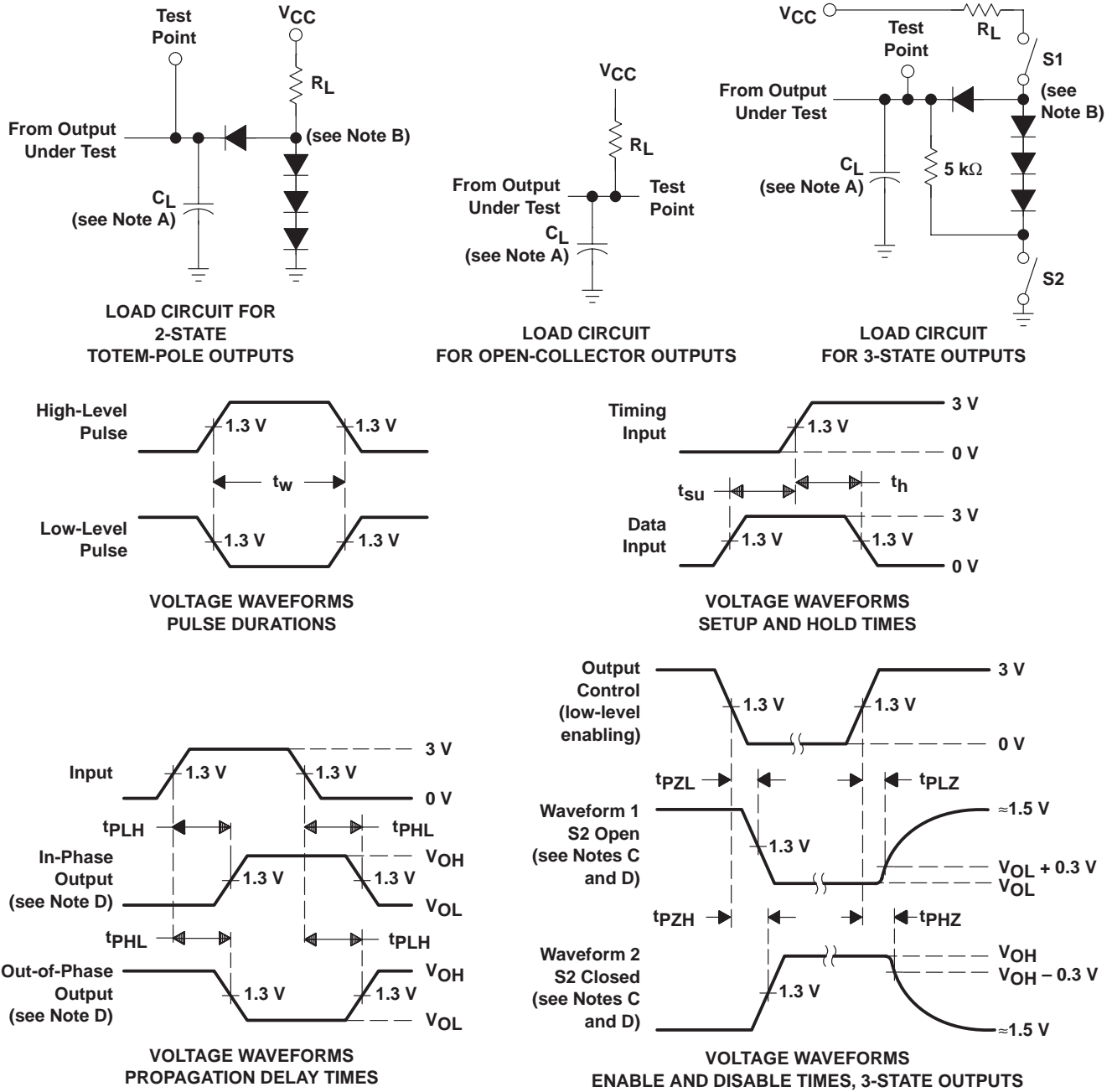
- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. All diodes are 1N3064 or equivalent.  
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 D. S1 and S2 are closed for  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_{PHZ}$ , and  $t_{PLZ}$ ; S1 is open and S2 is closed for  $t_{PZH}$ ; S1 is closed and S2 is open for  $t_{PZL}$ .  
 E. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O \approx 50 \Omega$ ,  $t_r$  and  $t_f \leq 7$  ns for Series 54/74 devices and  $t_r$  and  $t_f \leq 2.5$  ns for Series 54S/74S devices.  
 F. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

**SN54173, SN54LS173A, SN74173, SN74LS173A**  
**4-BIT D-TYPE REGISTERS**  
**WITH 3-STATE OUTPUTS**

SDLS067A – OCTOBER 1976 – REVISED JUNE 1999

**PARAMETER MEASUREMENT INFORMATION**  
**SERIES 54LS/74LS DEVICES**



- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. All diodes are 1N3064 or equivalent.  
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 D. S1 and S2 are closed for  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_{PHZ}$ , and  $t_{PLZ}$ ; S1 is open and S2 is closed for  $t_{PZH}$ ; S1 is closed and S2 is open for  $t_{PZL}$ .  
 E. Phase relationships between inputs and outputs have been chosen arbitrarily for these examples.  
 F. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1$  MHz,  $Z_O \approx 50 \Omega$ ,  $t_r \leq 15$  ns,  $t_f \leq 6$  ns.  
 G. The outputs are measured one at a time with one input transition per measurement.

**Figure 2. Load Circuits and Voltage Waveforms**

## IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

This datasheet has been downloaded from:

[www.DatasheetCatalog.com](http://www.DatasheetCatalog.com)

Datasheets for electronic components.